

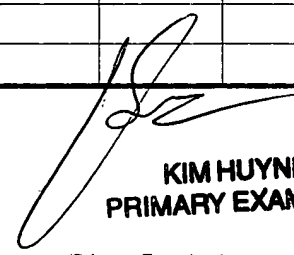
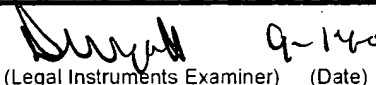


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/614,864	INOUE, YASUO	
	Examiner	Art Unit	
	Alan S. Chen	2182	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
710	2			710	8	26	72			
INTERNATIONAL CLASSIFICATION										
G	0	6	F							
				3/00						
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				/						
				/						
 9/12/05 (Assistant Examiner) (Date)				 <b>KIM HUYNH</b> <b>PRIMARY EXAMINER</b> (Primary Examiner)				Total Claims Allowed: 15		
 9-14-05 (Legal Instruments Examiner) (Date)				(Date) 9/12/05				O.G. Print Claim(s) 1	O.G. Print Fig. 7	

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input checked="" type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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